

Search Notes

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Examiner

Trinh T. Nguyen

Applicant(s)/Patent under
Reexamination

JEONG, BYEONG HEE

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
47	41.01 41.12 41.13 41.14 41.15	6/5/2008	TTN
	62R 62A 62N		
	79 48.5 80		
	81		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search was performed.	6/5/2008	TTN